





OTA TEST REPORT

Applicant Espressif System (Shanghai) Co.,Ltd

Product ESP32-C3-WROOM-02

Model ESP-ANT B

Report No. Y2102A0260-T3

Issue Date March 9, 2021

TA Technology (Shanghai) Co., Ltd. tested the above equipment in accordance with the requirements in **ANSI/IEEE Std 149-2008.** The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

Prepared by: Peng Tao

Approved by: Kai Xu

TA Technology (Shanghai) Co., Ltd.

No.145, Jintang Rd, Tangzhen Industry Park, Pudong Shanghai, China TEL: +86-021-50791141/2/3 FAX: +86-021-50791141/2/3-8000



TABLE OF CONTENTS

1.	Test Laboratory			
	1.1.	Notes of the Test Report	3	
	1.2.	Test facility	3	
	1.3.	Testing Location	3	
	1.4.	Laboratory Environment	4	
2.	Gener	al Description of Equipment under Test	5	
	2.1.	Applicant and Manufacturer Information	5	
	2.2.	General information	5	
	2.3.	Test Date	5	
	2.4.	Receiving Date	5	
	2.5.	Applied Standards	6	
	2.6.	Antenna size diagram	6	
3.	Test C	Conditions	7	
	3.1.	Test Configuration	7	
	3.2.	Test Measurement	7	
4.	Test F	Results	8	
	4.1.	Gain and Efficiency	8	
5.	Equip	ment List	9	
ANNE	X A 3-	D Pattern Plots	10	
ANNE	XB: Th	ne EUT Appearance and Test Configuration	12	
	B.1 El	JT Appearance	12	
	B.2 Te	est Configuration	13	



1. Test Laboratory

1.1. Notes of the Test Report

This report shall not be reproduced in full or partial, without the written approval of **TA technology** (shanghai) co., Ltd. The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein .Measurement Uncertainties were not taken into account and are published for informational purposes only. This report is written to support regulatory compliance of the applicable standards stated above.

Report No: Y2102A0260-T3

1.2. Test facility

A2LA (Certificate Number: 3857.01)

TA Technology (Shanghai) Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform measurement.

1.3. Testing Location

Company: TA Technology (Shanghai) Co., Ltd.

Address: No.145, Jintang Rd, Tangzhen Industry Park, Pudong Shanghai, China

City: Shanghai

Post code: 201201

Country: P. R. China

Contact: Xu Kai

Telephone: +86-021-50791141/2/3

Fax: +86-021-50791141/2/3-8000

Website: http://www.ta-shanghai.com

E-mail: xukai@ta-shanghai.com



Report No: Y2102A0260-T3

1.4. Laboratory Environment

Temperature	Min. =19℃,Max. = 25℃		
Relative humidity	Min. =40%,Max. =72%		
Shield effect	0.7-6GHz	> 100dB	
Ground resistance	<0.5Ω	2	





DTA Test Report No: Y2102A0260-T3

2. General Description of Equipment under Test

2.1. Applicant and Manufacturer Information

Applicant Name	Espressif System (Shanghai) Co.,Ltd		
Applicant address	Suite 204 Block 2, 690 Bibo Road, Zhang Jiang Hi-Tech Park, Shanghai, China		
Manufacturer Name	Espressif System (Shanghai) Co.,Ltd		
Manufacturer address	Suite 204 Block 2, 690 Bibo Road, Zhang Jiang Hi-Tech Park, Shanghai, China		

2.2. General information

EUT Description			
ESP32-C3-WROOM-02			
ESP-ANT B			
ESP32-C3-WROOM-02 V1			
esp32c3_phy_20210225_no_sleep_and_ampdu			
PCB Antenna			
Espressif System (Shanghai) Co.,Ltd			
2402MHz ~ 2502MHz			

Note: The EUT is sent from the applicant to TA and the information of the EUT is declared by the applicant.

All indications of Pass/Fail in this report are opinions expressed by TA Technology (Shanghai) Co., Ltd. based on interpretations and/or observations of test results. Measurement Uncertainties were not taken into account and are published for informational purposes only.

Test lab. of the antenna gain and radiation pattern measurement: TA Technology (Shanghai) Co., Ltd.

2.3. Test Date

The test is performed from February 25, 2021 to March 4, 2021.

2.4. Receiving Date

The sample was received on February 25, 2021.



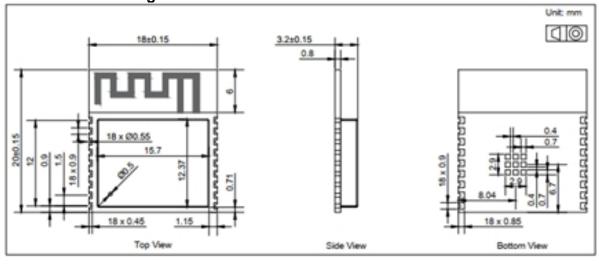
DTA TestReport Report No: Y2102A0260-T3

2.5. Applied Standards

According to the specifications of the manufacturer, it must comply with the requirements of the following standards:

Test Method: ANSI/IEEE Std 149-2008

2.6 Antenna size diagram





DTA Test Report No: Y2102A0260-T3

3. Test Conditions

3.1. Test Configuration

Great-Circle-Cut method is used to measure the antenna 3D GAIN of EUT in OTA qualified anechoic chamber. Equipment Under Test (EUT) geometry centre vertical projection at the centre of platform, the distance from EUT to measurement antenna is 5m.

3.2. Test Measurement

Spherical coordinate system

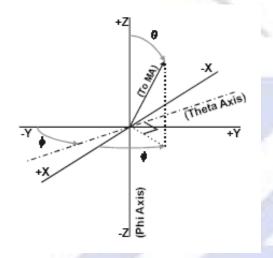
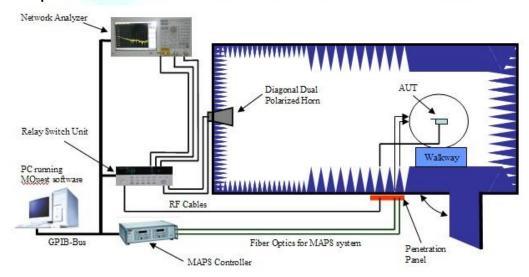


Figure 1 Test coordinate system

Note: Theta is from 0~180 degree. Phi is from 0~360. Rotate the EUT and record the Data, the step of rotation is 15 degree.

Test Setup





TA TestReport Report No: Y2102A0260-T3

4. Test Results

4.1. Gain and Efficiency

Model	Test State	Frequency (MHz)	Efficiency (dB)	Efficiency (%)	Gain (dBi)	Directivity (dBi)	Note
	Free Space	2402	-1.98	63.44	2.73	4.70	
		2407	-1.76	66.66	2.73	4.50	
		2412	-1.70	67.68	3.16	4.85	
		2417	-1.60	69.11	2.92	4.53	
		2422	-1.61	68.95	2.79	4.41	
		2427	-1.77	66.48	2.29	4.06	
/ 10/		2432	-1.83	65.54	2.54	4.37	
ALC: U		2437	-1.73	67.21	2.46	4.19	
2.00		2442	-1.77	66.46	2.56	4.34	
		2447	-1.79	66.25	2.69	4.48	15°
ESP-ANT B		2452	-1.75	66.81	2.95	4.70	
		2457	-1.76	66.73	2.96	4.71	
100		2462	-1.68	67.91	2.99	4.67	
1000		2467	-1.95	63.90	3.17	5.11	
		2472	-2.07	62.14	3.08	5.14	7
		2477	-1.87	65.00	3.18	5.05	1
		2482	-1.94	63.96	3.26	5.20	
7 15		2487	-1.98	63.35	3.37	5.35	
1.7		2492	-1.82	65.80	3.35	5.17	
		2497	-1.72	67.34	3.17	4.88	
		2502	-1.75	66.79	3.18	4.94	



Report No: Y2102A0260-T3

5. Equipment List

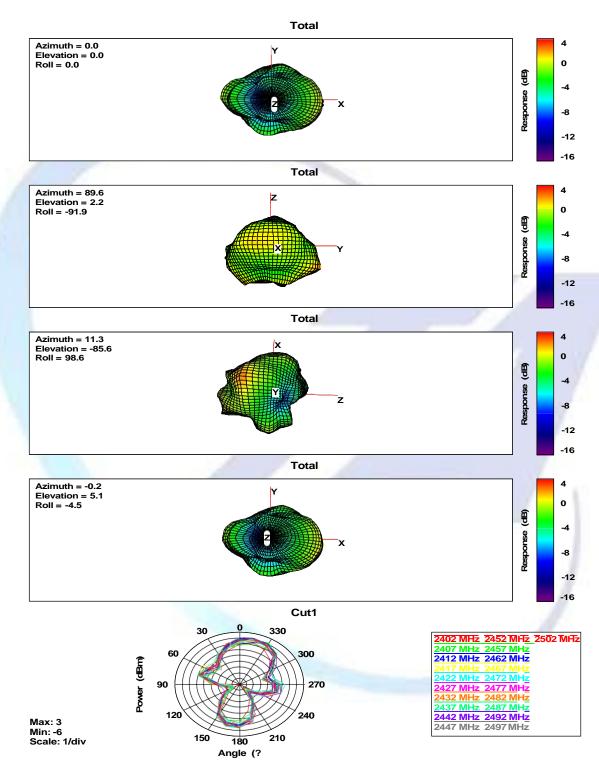
Type of Equipment	Manufacture	Model Number	S/N	Calibration Date	Expiration Time
Network Analyzer	Key sight	E5071B	MY42404014	2020-05-17	2021-05-16
Switch Control System	ETS	7006/7001	00059957/MY 42001152	N/A	N/A
Dual polarized horn antenna	ETS	3164-04	00062743	2020-04-14	2021-04-13
Software	ETS-lindgren	EMQ-100 Pattern Measurement software	1.09	N/A	N/A

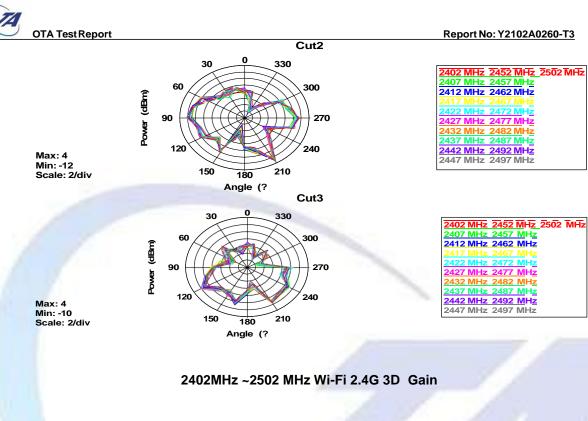


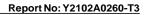


A Test Report No: Y2102A0260-T3

ANNEX A 3-D Pattern Plots



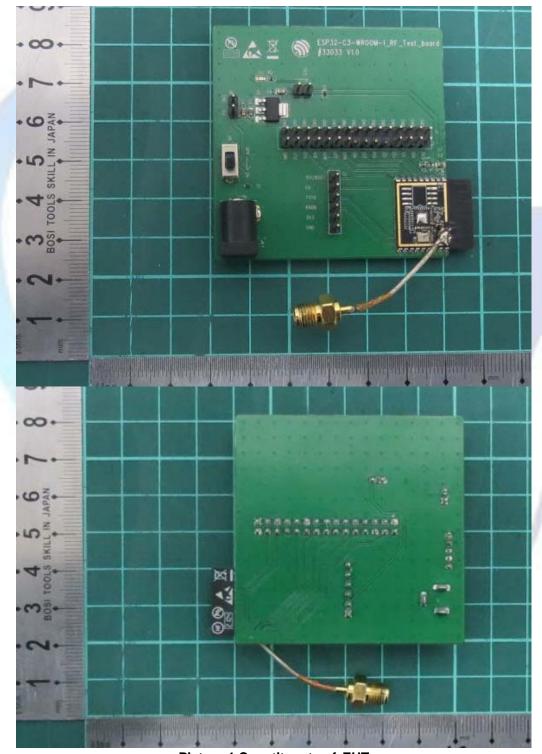






ANNEX B: The EUT Appearance and Test Configuration

B.1 EUT Appearance



Picture 1 Constituents of EUT



B.2 Test Configuration



Picture 2 Test Setup ******END OF REPORT ******